Se	arch No	tes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/815,370	YEH ET AL.	
Examiner	Art Unit	
TRONG PHAN	2827	

	SEARCHED			
Class	Subclass	Date	Examiner	
365	185.03	12/21/2005	TP	
	185.11	5/14/2006	TP	
	185.18			
	185.28			
	185.29			
	185.33			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
All above se	arch updated	5/14/2006	TP

SEARCH NO (INCLUDING SEARCH	TES STRATEGY)	<u> </u>
	DATE	EXMR
EAST Inventor Name Search in PALM	12/21/2005	TP
	5/14/2006	ТР